

Atty.
Dkt. No.

M#

Client Ref.

256642

2000182

**INFORMATION DISCLOSURE STATEMENT
BY APPLICANT**

Applicant: JENDICK

Appln. No.: 09/412,362

Filing Date: October 5, 1999

Date: August 21, 2002

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of

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Examiner: L. Huynh

Group Art Unit: 3721

U.S. PATENT DOCUMENTS

Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
<i>SKH</i>	AR 3,281,024	10/1966	HENCHERT et al.			
<i>SKH</i>	BR 3,627,858	12/1971	PARTS et al.			
<i>SKH</i>	CR 3,796,344	05/1974	DE PHILLIPS et al.			
<i>SKH</i>	DR 3,822,496	07/1974	MINDER			
<i>SKH</i>	ER 3,958,354	05/1976	HOUGH et al.			
<i>SKH</i>	FR 4,331,256	05/1982	HELMS			
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<i>SKH</i>	HR 4,517,436	05/1985	LAWRENCE			
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<i>SKH</i>	JR 4,578,329	03/1986	HOLSAPPEL			
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FOREIGN PATENT DOCUMENTS

ORIGINAL WHEN DOCUMENTED							Abstract		Readily Available	
		Document Number	Date MM/YYYY	Country	Inventor Name		Enclosed	No	Enclose	No
SKH	OR	1,124,958	12/1965	UK						
SKH	PR	GB 2320008 A	06/1998	UK						
SKH	QR	WO 97/47397	12/1997	PCT						
SKH	RR	DE 19701547	03/1998	GERMANY			X			
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SKH	TR	JP 5-178346	07/1993	JAPAN			X			
SKH	UR	FR 2649628	01/1991	FRANCE			X			
SKH	VR	FR 2750396	01/1998	FRANCE			X			
SKH	WR	DE 4103746	08/1992	GERMANY			X			
SKH	XR	DE 29816109	07/1999	GERMANY					X	

OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

YR				
ZR				
AAR				
BBR				
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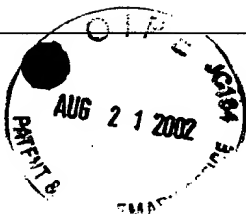
Examiner

Louis L. Huynh

Date Considered:

9/12/02

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.



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Date: August 21, 2002 Page 2 of 2

U.S. PATENT DOCUMENTS

Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
<i>AKH</i>	EER 5,416,951	05/1995	KEYAKI et al.			
<i>AKH</i>	FFR 5,492,077	02/1996	ROSE			
<i>AKH</i>	GGR 5,523,125	06/1996	KENNEDY et al.			
<i>AKH</i>	HHR 5,635,900	08/1997	CLEMENT et al.			
<i>AKH</i>	IIR 5,799,815	09/1998	LANG			
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<i>AKH</i>	OOR DES. 289,017	03/1987	SPANGLER et al.			
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					Enclosed	No	Enclose	No
<i>AKH</i>	SSR EP 0289022	11/1988	EUROPE					
<i>AKH</i>	TTR DE 2052512	04/1972	GERMANY				X	
<i>AKH</i>	UUR EP 0208175	01/1987	EUROPE					
	VVR							
	WW							
	XXR							
	YYR							
	ZZR							
	AAA							
	BBB							

OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

	CCC				
	DDD				
	EEE				
	FFF				
	GGG				
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Examiner *L. Huynh* Date Considered: *9/12/02*

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